Docket No.: 60188-637 PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Takashi YONEDA, et al. : Confirmation Number:

Serial No.: : Group Art Unit:

Filed: August 26, 2003 : Examiner:

For: SEMICONDUCTOR INTEGRATED CIRCUIT

INFORMATION DISCLOSURE STATEMENT

Mail Stop Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

The relevance of each non-English language reference, if any, is discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Date: August 26, 2003

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION		ATTY. DOCKET NO. 60188-637 APPLICANT Takashi YONEDA, et al.							
(PTO-1449)			FILING DATE GROUP August 26, 2003			P			
			U.S. PATEN	T DOCUMENTS					
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document					
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		UD 0 404040 4 4 5 111					Yes	No	
		JP-6-131218 (w/ English Abstract)	05/13/1994	FUJITSU LTD.					
	 								
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.